

FORM PTO-1449		U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. <b>10/552265</b>		U 015960-5								
INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (Use several sheets if necessary)				APPLICANT										
				Marco ANGELINI et al.										
				FILING DATE		GROUP								
				8/11/2006		2885								
U. S. PATENT DOCUMENTS														
EXAMINER INITIALS	REFERENCE DESIGNATION	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE									
/DM/	AA	6,154,282	11/2000	Lilge et al.										
<div style="position: relative; height: 100px;"> <div style="position: absolute; top: 0; left: 0; right: 0; bottom: 0; background: linear-gradient(to bottom right, transparent 49%, black 49%, black 51%, transparent 51%);"></div> </div>														
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FOREIGN PATENT DOCUMENTS														
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION									
					YES	NO								
/DM/	AL	01/61324	08/2001	WO										
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							AM							
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OTHER ART (Including Author, Title, Date, Pertinent Dates, Etc.)														
/DM/	AQ	Herman, P. et al. "Frequency-Domain Fluorescence Microscopy with the LED as a Light Source" <i>Journal of Microscopy</i> (2001) Vol. 204, Pt 2, No. 8, pp 176-181 XP-002290940												
/DM/	AR	Silk, E. "LED Fluorescence Microscopy in Theory and Practice" <i>Microscope</i> (2002) Vol. 50, No. 2-3, pp 101-118												
	AS	Mazzini, G. et al. "Light Emitting Diodes as Possible Excitation Source for Fluorescence Microscopy and Cytometry" <i>Focus on Microscopy, Online</i> (2003) XP-002290942 <a href="http://www.focusonmicroscopy.org/2003/index.html">http://www.focusonmicroscopy.org/2003/index.html</a>												
EXAMINER		/David Makiya/		DATE CONSIDERED 06/12/2008										
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														